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#### **60V COMPLEMENTARY PAIR ENHANCEMENT MODE MOSFET**

#### **Product Summary**

| Device       | BV <sub>DSS</sub> | R <sub>DS(ON)</sub> Max                      | I <sub>D</sub><br>T <sub>A</sub> = +25°C |  |
|--------------|-------------------|--|--|--|
| Q1 N-Channel | 60V               | $40 \text{m}\Omega$ @ $V_{GS} = 10 \text{V}$ | 6.5A                                     |  |
| QT N-Channel | 60 V              | $55m\Omega @ V_{GS} = 4.5V$                  | 5.6A                                     |  |
| Q2 P-Channel | -60V              | 110mΩ @ V <sub>GS</sub> = -10V               | -3.9A                                    |  |
| Q2 P-Channel | -60 V             | 130mΩ @ $V_{GS} = -4.5V$                     | -3.6A                                    |  |

## **Description and Applications**

This MOSFET is designed to meet the stringent requirements of automotive applications. It is qualified to AEC-Q101, supported by a PPAP and is ideal for use in:

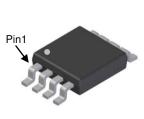
- DC-DC Converters
- Power Management Functions
- Backlighting

#### **Features and Benefits**

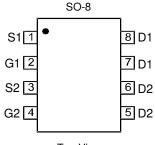
- Low Input Capacitance
- Low On-Resistance
- Fast Switching Speed
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability
- PPAP Capable (Note 4)

#### **Mechanical Data**

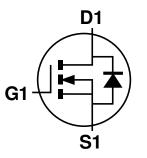
- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound.
  UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Finish Tin Finish Annealed over Copper Leadframe.
  Solderable per MIL-STD-202, Method 208 <sup>3</sup>
- Weight: 0.074 grams (Approximate)



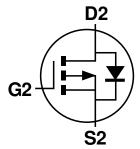
Top View



Top View Pin Configuration



Q1 N-Channel MOSFET



Q2 P-Channel MOSFET

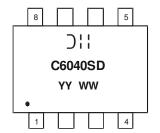
#### **Ordering Information** (Note 5)

| Ī | Part Number    | Case | Packaging         |
|---|----------------|------|-------------------|
|   | DMC6040SSDQ-13 | SO-8 | 2,500/Tape & Reel |

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com/quality/lead\_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. Automotive products are AEC-Q101 qualified and are PPAP capable. Refer to http://www.diodes.com/product\_compliance\_definitions.html
- 5. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

# **Marking Information**



);; = Manufacturer's Marking C6040SD = Product Type Marking Code YYWW = Date Code Marking YY or YY = Year (ex: 16 = 2016) WW = Week (01 - 53)



#### Maximum Ratings (@TA = +25°C, unless otherwise specified.)

| Characteristic   | Symbol          | Q1   | Q2             | Units      |              |    |
|--|-----------------|--|----------------|------------|--------------|----|
| Drain-Source Voltage                                     | $V_{DSS}$       | 60   | -60            | V          |              |    |
| Gate-Source Voltage                                      | $V_{GSS}$       | ±20  | ±20            | V          |              |    |
| Continuous Drain Current (Note 7) // 10//                | Steady<br>State | $T_A = +25^{\circ}C$<br>$T_A = +70^{\circ}C$ | I <sub>D</sub> | 5.1<br>4.1 | -3.1<br>-2.5 | А  |
| Continuous Drain Current (Note 7) V <sub>GS</sub> = -10V | t<10s           | $T_A = +25^{\circ}C$<br>$T_A = +70^{\circ}C$ | I <sub>D</sub> | 6.5<br>5.2 | -3.9<br>-3.1 | А  |
| Maximum Body Diode Forward Current (Note 7)              |                 | Is   | 2.1            | -2.1       | Α            |    |
| Pulsed Drain Current (10µs Pulse, Duty Cycle =           | I <sub>DM</sub> | 28   | -19            | Α          |              |    |
| Avalanche Current (Note 8) L = 0.1mH                     | I <sub>AS</sub> | 17.2   | -17.6          | Α          |              |    |
| Avalanche Energy (Note 8) L = 0.1mH                      |                 |  | Eas            | 14.7       | 15.4         | mJ |

### Thermal Characteristics (@T<sub>A</sub> = +25°C, unless otherwise specified.)

| Characteristic                                   | Symbol               | Value                            | Units       |      |
|--|----------------------|----------------------------------|-------------|------|
| Total Power Discipation (Note 6)                 | $T_A = +25^{\circ}C$ | D                                | 1.24        | W    |
| Total Power Dissipation (Note 6)                 | $T_A = +70^{\circ}C$ | $P_{D}$                          | 0.8         |      |
| Thermal Resistance, Junction to Ambient (Note 6) | Steady State         | Р                                | 101         | °C/W |
| Thermal Resistance, Junction to Ambient (Note 6) | t < 10s              | $R_{\theta JA}$                  | 61          |      |
| Total Power Discinction (Note 7)                 | $T_A = +25$ °C       | В                                | 1.56        | °C/W |
| Total Power Dissipation (Note 7)                 | $T_A = +70^{\circ}C$ | $P_{D}$                          | 1.0         |      |
| Thermal Resistance, Junction to Ambient (Note 7) | Steady State         | Р                                | 80          |      |
| Thermal Resistance, Junction to Ambient (Note 7) | t<10s                | $R_{\theta JA}$                  | 49          |      |
| Thermal Resistance, Junction to Case (Note 7)    | $R_{	heta JC}$       | 14.7                             |             |      |
| Operating and Storage Temperature Range          |                      | T <sub>J,</sub> T <sub>STG</sub> | -55 to +150 | °C   |

# Electrical Characteristics - N-Channel Q1 (@T<sub>A</sub> = +25°C, unless otherwise specified.)

| Characteristic                             | Symbol              | Min | Тур   | Max  | Unit  | Test Condition  |  |
|--|---------------------|-----|-------|------|-------|---|--|
| OFF CHARACTERISTICS (Note 9)               |                     |     |       |      |       |   |  |
| Drain-Source Breakdown Voltage             | BV <sub>DSS</sub>   | 60  | _     | _    | V     | $V_{GS} = 0V, I_D = 250\mu A$   |  |
| Zero Gate Voltage Drain Current            | I <sub>DSS</sub>    | _   | _     | 1    | μΑ    | $V_{DS} = 48V, V_{GS} = 0V$   |  |
| Gate-Source Leakage                        | I <sub>GSS</sub>    | _   | _     | ±100 | nA    | $V_{GS} = \pm 20V, V_{DS} = 0V$   |  |
| ON CHARACTERISTICS (Note 9)                |                     |     |       |      |       |   |  |
| Gate Threshold Voltage                     | V <sub>GS(TH)</sub> | 1   | _     | 3    | V     | $V_{DS} = V_{GS}$ , $I_D = 250\mu A$  |  |
| Static Drain-Source On-Resistance          |                     |     | 33    | 40   | mΩ    | $V_{GS} = 10V, I_D = 8A$  |  |
| Static Diani-Source On-Nesistance          | R <sub>DS(ON)</sub> |     | 37    | 55   | 11122 | $V_{GS} = 4.5V, I_D = 5A$   |  |
| Diode Forward Voltage                      | $V_{SD}$            |     | 0.7   | 1.2  | V     | $V_{GS} = 0V, I_{S} = 1A$   |  |
| DYNAMIC CHARACTERISTICS (Note 10)          |                     |     |       |      |       |   |  |
| Input Capacitance                          | C <sub>ISS</sub>    |     | 1,130 |      |       | $V_{DS} = 15V, V_{GS} = 0V f = 1.0MHz$  |  |
| Output Capacitance                         | Coss                | _   | 69    |      | pF    |   |  |
| Reverse Transfer Capacitance               | Crss                | _   | 42    | _    |       |   |  |
| Gate Resistance                            | R <sub>G</sub>      |     | 1.7   | _    | Ω     | $V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$  |  |
| Total Gate Charge (V <sub>GS</sub> = 10V)  | Q <sub>G</sub>      |     | 20.8  | _    |       | V 00V L 40A   |  |
| Total Gate Charge (V <sub>GS</sub> = 4.5V) | $Q_{G}$             |     | 9.4   | _    | nC    |   |  |
| Gate-Source Charge                         | $Q_{GS}$            | _   | 3.3   | _    | IIC   | $V_{DS} = 30V, I_D = 4.3A$  |  |
| Gate-Drain Charge                          | Q <sub>GD</sub>     | _   | 3.0   | _    |       |   |  |
| Turn-On Delay Time                         | t <sub>D(ON)</sub>  |     | 3.6   | _    |       | $\begin{aligned} &V_{GS}=10V,V_{DD}=30V,R_{G}=6\Omega,\\ &I_{D}=4.3A \end{aligned}$ |  |
| Turn-On Rise Time                          | t <sub>R</sub>      | _   | 1.8   | _    | ns    |   |  |
| Turn-Off Delay Time                        | t <sub>D(OFF)</sub> | _   | 20.1  | _    | 115   |   |  |
| Turn-Off Fall Time                         | t <sub>F</sub>      | _   | 4.3   | _    |       |   |  |
| Body Diode Reverse Recovery Time           | t <sub>RR</sub>     |     | 14.2  | _    | ns    | $I_S = 4.3A$ , $dI/dt = 100A/\mu s$   |  |
| Body Diode Reverse Recovery Charge         | Q <sub>RR</sub>     | _   | 7.5   | _    | nC    | $I_S = 4.3A$ , $dI/dt = 100A/\mu s$   |  |

Notes: 6. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.

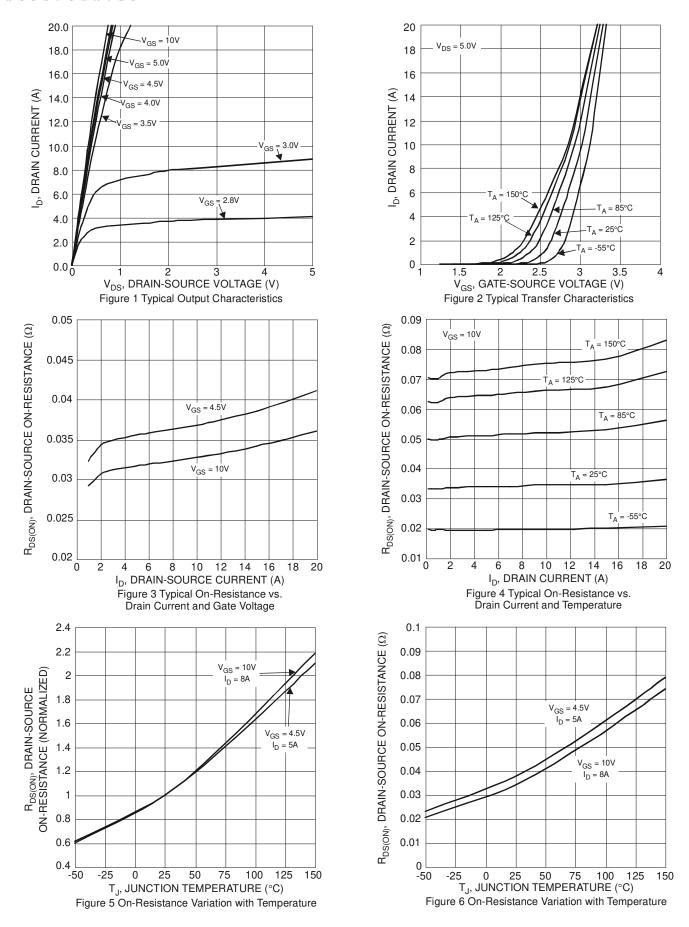
<sup>7.</sup> Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.

<sup>8.</sup> UIS in production with L = 0.1mH, starting  $T_A$  = +25°C.

<sup>9.</sup> Short duration pulse test used to minimize self-heating effect.

<sup>10.</sup> Guaranteed by design. Not subject to product testing.







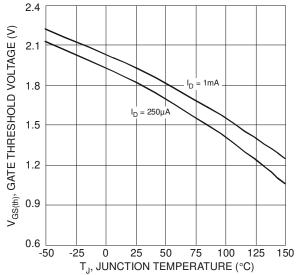
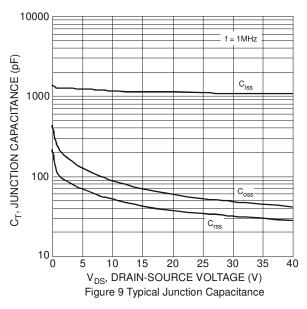
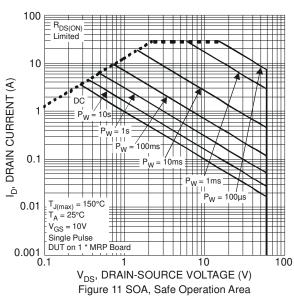
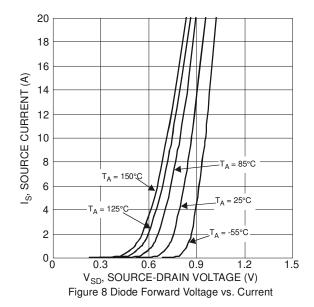
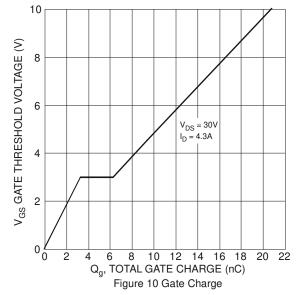


Figure 7 Gate Threshold Variation vs. Ambient Temperature

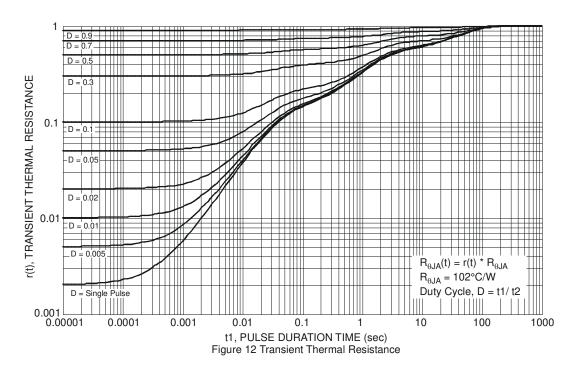












Electrical Characteristics – P-Channel Q2 (@T<sub>A</sub> = +25°C, unless otherwise specified.)

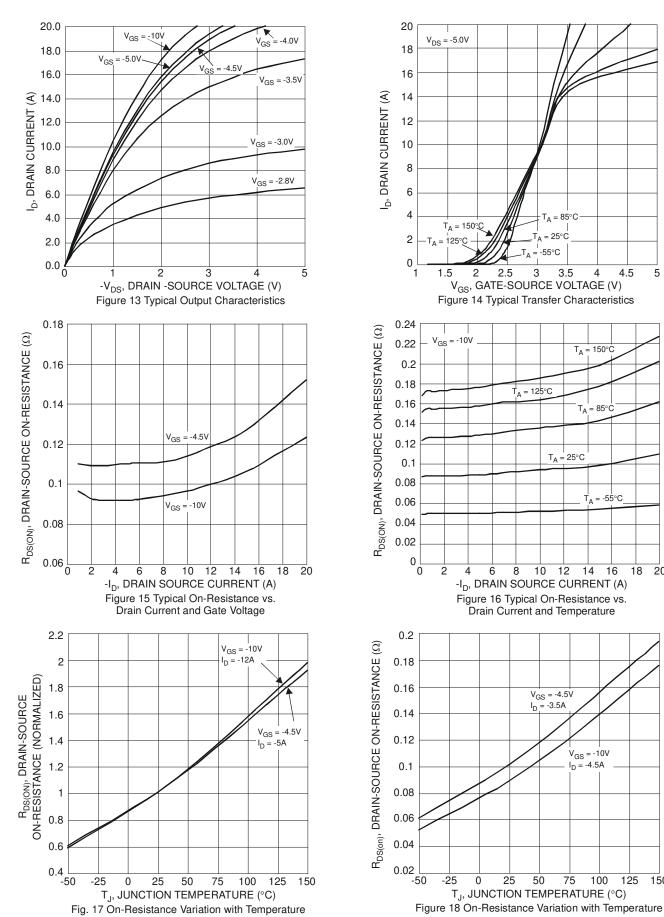
| Characteristic                              | Symbol              | Min | Тур   | Max  | Unit  | Test Condition  |  |  |  |
|---|---------------------|-----|-------|------|-------|---|--|--|--|
| OFF CHARACTERISTICS (Note 9)                |                     |     |       |      |       |   |  |  |  |
| Drain-Source Breakdown Voltage              | BV <sub>DSS</sub>   | -60 | _     | _    | V     | $V_{GS} = 0V, I_D = -250\mu A$                            |  |  |  |
| Zero Gate Voltage Drain Current             | I <sub>DSS</sub>    | _   | _     | -1   | μΑ    | V <sub>DS</sub> = -48V, V <sub>GS</sub> = 0V              |  |  |  |
| Gate-Source Leakage                         | I <sub>GSS</sub>    | _   | _     | 100  | nA    | $V_{GS} = \pm 16V, V_{DS} = 0V$                           |  |  |  |
| ON CHARACTERISTICS (Note 9)                 |                     |     |       |      |       |   |  |  |  |
| Gate Threshold Voltage                      | V <sub>GS(TH)</sub> | -1  | _     | -3   | V     | $V_{DS} = V_{GS}, I_{D} = -250 \mu A$                     |  |  |  |
| Static Dynin Source On Decistance           |                     | _   | 91    | 110  | mΩ    | $V_{GS} = -10V, I_D = -4.5A$                              |  |  |  |
| Static Drain-Source On-Resistance           | R <sub>DS(ON)</sub> | _   | 110   | 130  | 11177 | $V_{GS} = -4.5V, I_D = -3.5A$                             |  |  |  |
| Diode Forward Voltage                       | $V_{SD}$            | _   | -0.7  | -1.2 | V     | $V_{GS} = 0V, I_{S} = -1A$                                |  |  |  |
| DYNAMIC CHARACTERISTICS (Note 10)           |                     |     |       |      |       |   |  |  |  |
| Input Capacitance                           | C <sub>ISS</sub>    |     | 1,030 |      |       |   |  |  |  |
| Output Capacitance                          | Coss                |     | 49.1  | _    | pF    | $V_{DS} = -30V, V_{GS} = 0V, f = 1.0MHz$                  |  |  |  |
| Reverse Transfer Capacitance                | C <sub>RSS</sub>    |     | 38.7  | _    |       |   |  |  |  |
| Gate Resistance                             | $R_{G}$             | _   | 13.6  | _    | Ω     | $V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$                    |  |  |  |
| Total Gate Charge (V <sub>GS</sub> = -4.5V) | $Q_{G}$             | _   | 9.5   | _    |       | V 00V I 5A  |  |  |  |
| Total Gate Charge (V <sub>GS</sub> = -10V)  | $Q_{G}$             | _   | 19.4  | _    | nC    |   |  |  |  |
| Gate-Source Charge                          | Q <sub>GS</sub>     | _   | 2.3   | _    | nc nc | $V_{DS} = -30V, I_{D} = -5A$                              |  |  |  |
| Gate-Drain Charge                           | $Q_{GD}$            | _   | 3.6   | _    |       |   |  |  |  |
| Turn-On Delay Time                          | t <sub>D(ON)</sub>  | _   | 3.7   | _    |       | $V_{GS} = -10V$ , $V_{DS} = -30V$ , $R_{GEN} = 6\Omega$ , |  |  |  |
| Turn-On Rise Time                           | t <sub>R</sub>      | _   | 6.3   | _    |       |   |  |  |  |
| Turn-Off Delay Time                         | t <sub>D(OFF)</sub> | _   | 58.7  | _    | ns    | $I_D = -5A$   |  |  |  |
| Turn-Off Fall Time                          | t <sub>F</sub>      |     | 26.1  | _    |       |   |  |  |  |
| Body Diode Reverse Recovery Time            | t <sub>RR</sub>     |     | 14.85 | _    | ns    | I <sub>S</sub> = -5A, dI/dt = 100A/μs                     |  |  |  |
| Body Diode Reverse Recovery Charge          | Q <sub>RR</sub>     |     | 8.8   | _    | nC    | I <sub>S</sub> = -5A, dI/dt = 100A/µs                     |  |  |  |

Notes: 9. Short duration pulse test used to minimize self-heating effect.

10. Guaranteed by design. Not subject to product testing.

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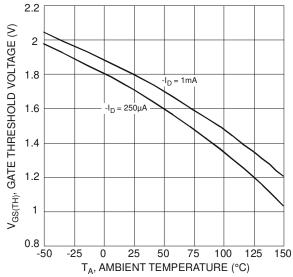
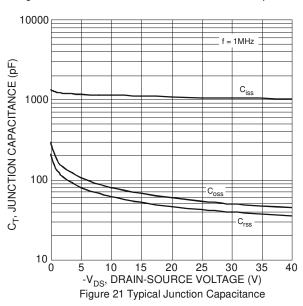
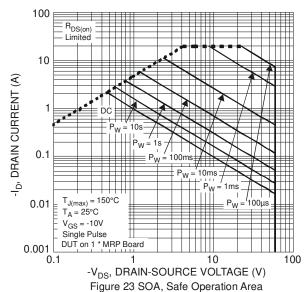
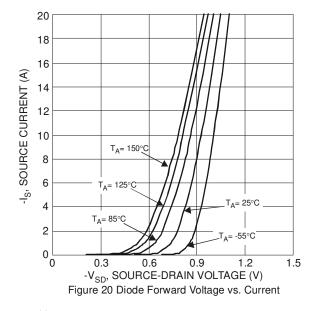
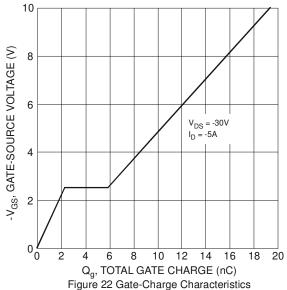


Figure 19 Gate Threshold Variation vs. Ambient Temperature







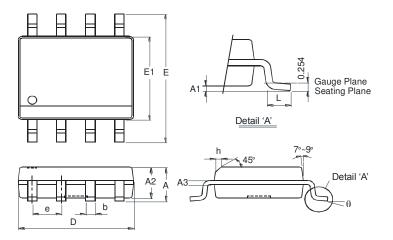




### **Package Outline Dimensions**

Please see http://www.diodes.com/package-outlines.html for the latest version.

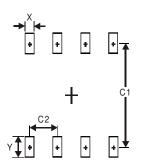




|                      | SO-8              |      |  |  |  |  |
|----------------------|-------------------|------|--|--|--|--|
| Dim                  | Min               | Max  |  |  |  |  |
| Α                    | -                 | 1.75 |  |  |  |  |
| A1                   | 0.10              | 0.20 |  |  |  |  |
| A2                   | 1.30              | 1.50 |  |  |  |  |
| A3                   | 0.15              | 0.25 |  |  |  |  |
| b                    | 0.3               | 0.5  |  |  |  |  |
| D                    | 4.85              | 4.95 |  |  |  |  |
| Е                    | 5.90              | 6.10 |  |  |  |  |
| E1                   | 3.85              | 3.95 |  |  |  |  |
| е                    | <b>e</b> 1.27 Typ |      |  |  |  |  |
| h                    | 1                 | 0.35 |  |  |  |  |
| L                    | 0.62              | 0.82 |  |  |  |  |
| θ                    | 0°                | 8°   |  |  |  |  |
| All Dimensions in mm |                   |      |  |  |  |  |

# **Suggested Pad Layout**

Please see http://www.diodes.com/package-outlines.html for the latest version.



SO-8

| Dimensions | Value (in mm) |
|------------|---------------|
| X          | 0.60          |
| Υ          | 1.55          |
| C1         | 5.4           |
| CO         | 1 27          |



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